Se	arch	Note	es .

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/798,284	LEE ET AL.	
Examiner	Art Unit	
Hung Q. Dang	2621	

SEARCHED			
Class	Subclass	Date	Examiner
386	95, 105	8/20/2007	HQD
369	47.28, 59.25, 275.3	8/20/2007	HQD
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventors' Names Search	8/20/2007	НQD
USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	8/8/2007- 8/20/2007	HQD
consulted with Thai Tran	8/20/2007	HQD
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